Current-controlled magnetization dynamics in the spin-ip transistor

 $\tt X$ uhui W ang and G errit E . W . B auer K avli Institute of N anoScience, D elft U niversity of Technology, 2628 C J D elft, The N etherlands

Teruo Ono

Institute for Chemical Research, Kyoto University, Uji Kyoto 611-0011, Japan (Dated: October 28, 2021)

The current driven magnetization dynamics of a thin-lm, three magnetic term in aldevice (spin-ip transistor) is investigated theoretically. We consider a magnetization con guration in which all magnetizations are in the device plane, with source-drain magnetizations chosen exed and antiparallel, whereas the third contact magnetization is allowed to move in a weak anisotropy eld that guarantees thermal stability of the equilibrium structure at room temperature. We analyze the magnetization dynamics of the free layer under a dc source-drain bias current within the macrospin model and magneto-electronic circuit theory. A new tunable two-state behavior of the magnetization is found and the advantages of this phenomenon and potential applications are discussed.

I. INTRODUCTION

The current induced magnetization excitation predicted by Slonczewski and Berger 1,2 has attracted considerable attention and the prediction of current-induced magnetization reversal has been con rmed by many experiments in nano-pillar structure consisting of two ferrom agnetic layers with a high (\ xed") and a low (\free") coercivity, separated by a norm almetal spacer. 3,4,5,6 Meanwhile, the investigations of charge and spin transport in thin-lm m etallic conductors structured on a planar substrate have also been carried out. 7,8,9,10,11,12 The advantages of the planar structures are the exible design and the relative ease to fabricate multi-term in all structures. 13 Recently, nonlocal magnetization switching in a lateral spin valve structure has been demonstrated. 14 In the present article we present a theoretical study on the dynamics of a lateral spin valve consisting of a normal metal lim that is contacted by two magnetically hard ferromagnets. As sketched in Fig. 1, a slightly elliptic and magnetically soft ferromagnetic Im is assumed deposited on top of the normal metal to form a spin-ip transistor. 15 The magnetization direction of the source-drain contacts lies antiparallel to each other in the plane of the magnetization of the third (free) layer. The con guration in which the source-drain contact magnetizations are oriented perpendicular to the plane is considered elsew here. 16 A convenient and accurate tool to study the dynam ic properties of our device is the magnetoelectronic circuit theory (MECT) for charge and spin transport 5 combined with the Landau-Lifshitz-Gilbert equation in the m acrospin model. The spin ip scattering in normal and ferrom agnetic metals and the spin-pumping e ect are also taken into account. 17,18

The article is organized as the follows: In xII, we brie y review the MECT and Landau-Lifshitz-Gilbert equation for the macrospin model. In xIII, calculations of the spin transfer torque for our device are presented. xIV is devoted to the discussion of thermal (in)stability and in xV the magnetization dynamics is treated. The conclusions are summarized in xVI.

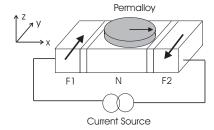


FIG. 1: The model system contains a normal metal sandwiched by two ferrom agnetic leads and a circular soft ferrom agnet lm (e.g., permalloy) on top of the normal metal. The magnetization unit vectors m 1, m 2, and m 3 are initially aligned in the same, i.e., x y plane.

II. MAGNETO-ELECTRONIC CIRCUIT THEORY

We rst consider a ferrom agnet-norm alm etal (F N) interface at quasi-equilibrium . The ferrom agnet at a chem ical potential $_0^F$ and spin accumulation $_s^F$ m aligned along the magnetization direction. The chem ical potential and spin accumulation in the normal metal are denoted by $_0^N$ and vector S. The charge current I_c (in the unit of Ampere) and the spin current I_s (in the unit of Joule) entering the normal metal node are given by, $_s^{15}$

$$\begin{split} &I_{c} = \frac{e}{2h} \ 2g(\begin{smallmatrix} F \\ 0 \end{smallmatrix}) + pg \begin{smallmatrix} F \\ 0 \end{smallmatrix}) + pg \begin{smallmatrix} F \\ S \end{smallmatrix} \quad pg \; (S \quad m \;) \\ &I_{s} = \frac{g}{8} \; [2p(\begin{smallmatrix} F \\ 0 \end{smallmatrix}) + \begin{smallmatrix} N \\ 0 \end{smallmatrix}) + \begin{smallmatrix} F \\ S \end{smallmatrix} \quad (1 \quad _{r}) \; (S \quad m \;)]m \\ &\frac{rg}{8} S \quad \frac{ig}{8} \; (S \quad m \;) \; ; \end{split} \tag{1}$$

From eq. (1) we may project out the component of I_s that is perpendicular to the magnetization direction and governs the spin transfer torque^{1,15}

m
$$J = \frac{rg}{8} [S \quad (S \quad m)_m] + \frac{ig}{8} (S \quad m) :$$
 (2)

In the above notations, the dimensionless total conductance $g = g'' + g^{\sharp}$ and the mixing conductance are given by Landauer-Buttiker formulae, i.e.,

$$g^{"(\#)} = M$$
 $f^{nm}_{(\#)} f$;

 $g^{"\#} = M$
 $f^{nm}_{(\#)} (r^{nm}_{\#})$;

(3)

where $r_{(\#)}^{n\,m}$ is the probability of a spin up (down) electron in mode mare ected into mode nain the normal metal and Mark is the total number of channels. The contact polarization is dened by $p=(g''+g^{\sharp})=(g''+g^{\sharp})$. The pumping current generated by the motion of the magnetization is 17

$$T_s^{(p)} = \frac{hg}{g} \qquad _r m \qquad \frac{dm}{dt} + \frac{dm}{i} \qquad : \tag{4}$$

We consider the situation in which the dimension of the normal metal is smaller than the spin-ip length, so that the spin accumulation does not vary spatially in the node.

$$I_{s}^{(f)} = \frac{g_{f}}{4}S \tag{5}$$

where $g_f = h_{DOS}V_N = f_f^N$, DOS and V_N are the density of states of the electrons and the volume of the normal metal, f_f^N is the spin- ip relaxation time in the normal metal node. The charge and spin currents entering the normal metal obey the conservation laws

$$X$$
 $I_{c;i} = 0;$
 X
 $I_{s;i} + I_{s;i}^{(p)} = I_{s}^{(f)};$
(6)

III. SPIN TRANSFER TORQUE

In the structure depicted in Fig. 1, the source-drain m agnetizations are aligned anti-parallelalong the y-axis in order to inject a large spin accumulation into N, i.e., m₁ = (0; +1; 0) and m₂ = (0; 1; 0). Connecting the ferrom agnets to reservoirs and applying a bias current I_0 via the two ferrom agnetic leads, the conservation of charge current dictates that $I_{c;1} = I_0$ and $I_{c;2} = I_0$ at the F1N and F2N interfaces, which gives

$${}_{0}^{\text{F1}} \quad {}_{0}^{\text{N}} = ({}_{0}^{\text{F2}} \quad {}_{0}^{\text{N}}) = \frac{I_{0}h}{\text{ge}} + \frac{1}{2}pS_{y}$$
: (7)

The free layer is electrically oating, hence there is no net charge current owing through F3N interface, $I_{c;3} = 0$. The spin accumulation in the free layer $_{s}^{F} = _{u}$ $_{\#}$, directed along magnetization m $_{3}$, is governed by the spin di usion equation, $_{19}^{19}$

$$\frac{{\color{red} \varrho^2} {\color{red} g} {\color{red} g} {\color{red} (z)}}{{\color{red} \varrho} {\color{red} z}^2} = \frac{{\color{red} g} {\color{red} g} {\color{red} (z)}}{{\color{red} 1} {\color{red} 2} {\color{red} g} {\color{red} (z)}} \tag{8}$$

which satis es the following boundary conditions. At the interface the continuity of longitudinal spin current dictates

"
$$\frac{\theta}{\theta z}$$
" $= \frac{\theta}{\theta z}$ $= \frac{\theta}{\theta z}$ $= \frac{2e^2}{hA} I_{s;3}$ rg (9)

and the vanishing spin current at the end of the ferrom agnet in plies

"
$$\frac{\theta}{\theta z}$$
" $= 0$: (10)

The solution of eq. (8) reads

$$F_{s}(z) = \frac{1}{h} \frac{3 \cosh\left(\frac{z}{l_{sd}}\right) m_{3}}{1} S$$

$$\frac{1}{3 + c \tanh\left(\frac{d}{l_{sd}}\right) \cosh\left(\frac{d}{l_{sd}}\right)}$$

$$(11)$$

where $_3 = g_3$ (1 g_3^2)=8 characterizes the contact F3N and $\sim = hA$ " $_{\#} = (e^2 l_{sd} (_{\#} + _{\#}))$ describes the bulk properties of the free layer with arbitrary m $_3$. The conservation of spin currents in eq. (6) generates three linear equations that determ ine the spin accumulation S in the normal metal as

$$S = (g;g_3) \ 8 \ I_S^{(p)} + W_b$$
 (12)

$$L = \frac{393}{8} \, (g;g) \, 8 \, I_s^{(p)} + W_b$$
 (13)

and the components of the matrix (g;g) are listed in the Appendix.

IV. THERMAL STABILITY

The spin transfer torque rotates the magnetization out of the equilibrium hence increasing the magnetostatic energy E_{MS} . The initial magnetization is stable against thermal uctuations when

$$E_{MS} > k_B T; (14)$$

where k_B is the Boltzm ann constant and T the temperature. For an elliptic permalloy lm, disregarding any residual crystalline anisotropy, the elective lm elliptic permalloy lm, disregarding any residual crystalline anisotropy, the elliptic permalloy lm, disregarding any residual crystalline anisotropy.

$$H_{e} = {}_{0}M_{s} (N_{x}m_{x}; N_{y}m_{y}; N_{z}m_{z});$$

$$(15)$$

introducing the saturation m agnetization M $_{\rm S}$ and dem agnetizing factors N $_{\rm X}$, N $_{\rm Y}$ and N $_{\rm Z}$ 20 . When the m agnetization is slightly out of plane, the difference between the magnetostatic energy for magnetizations along the hard-axis and easy-axis reads E $_{\rm M~S}$ = $_{\rm 0}$ V M $_{\rm S}$ (N $_{\rm Y}$ N $_{\rm X}$)=2. For a very at ellipsoid (the thickness is much smaller than the lateral dimensions) and slight ellipticity (large aspect ratio 1), we can expand the demagnetizing factors at = 1 such that

$$N_y N_x = \frac{d(^2 + 4 + 1)(1)}{4a(+1)};$$
 (16)

where a, b and d are the lengths of easy-axis, hard axis and the thickness of the perm alloy lm. The aspect ratio is de ned as = b=a. The requirement $E_{MS} > k_B T$ gives

$$\frac{(^{2}+4+1)(1)}{(+1)^{2}} > \frac{8k_{B}T}{{}_{0}M_{s}^{2}{}^{2}ad^{2}}:$$
 (17)

The saturation m agnetization of perm alloy is M $_{\rm S}=8$ 10^5 A m 1 . For thickness d = 5 nm and easy axis a = 200 nm 9 , the right hand side of eq. (17) is at room temperature approximately = 8:36 10^3 and therefore stability requires that

$$1 \frac{2}{3}$$
; (18)

which suggests that even for almost circular permalloy discs, e.g., = 0.9, thermal uctuations around the equilibrium con quantion are small.

V. MAGNETIZATION DYNAM ICS

Here we focus on the free layer magnetization dynamics in the macrospin model. The Landau-Lifshitz-Gilbert (LLG) equation modied by the spin transfer torque [eq. (13)] reads

$$\frac{1}{dt} \frac{dm}{dt} = m \qquad H_e + \frac{0}{m} \qquad \frac{dm}{dt} + \frac{1}{VM_s} L : \tag{19}$$

Included in the torque term, i.e., Eq. (13), an expression

$$! \ 0 \ \frac{h_{3}^{2}g_{3}^{2}}{8 \ VM_{s}} \ (g;g)$$
 (20)

appears as an enhancem ent of the G ilbert dam ping, 17 which depends on the direction of the magnetization and shows tensor property of the pumping induced damping enhancement. When the conductance at the F3N contact is much larger than the source-drain contacts and the spin ip in the normal metal is negligible, i.e., g_3 g and g_3 g_{sf}, the tensor $^{!}$ oconverges to 21

$$\frac{hR e g_3^{"#}}{4 VM_s} = \begin{pmatrix} 1 & m_x^2 & m_x m_y & m_x m_z \\ m_x m_y & 1 & m_y^2 & m_y m_z & A \\ m_x m_z & m_y m_z & 1 & m_z^2 \end{pmatrix} (21)$$

which in the LLG equation reduces to a diagonal matrix

$$! \ ^{0} = \frac{hR \, eg_{3}^{"^{\#}}}{4 \, VM_{s}} \hat{1}$$
 (22)

and the coe cient in front of the m atrix is exactly the value derived for the single F N junction 17 . In the same l in it, the bias-driven term of the torque reads,

$$\frac{1}{VM_{s}}L_{b} = \frac{hpI_{0}}{2VM_{s}\dot{p}\dot{j}} \begin{pmatrix} 0 & 1 & 1 \\ 1 & m_{x}m_{y} & A \\ 1 & m_{y}m_{z} \end{pmatrix} A :$$
 (23)

In the following discussions, we denote the enhanced G ilbert damping parameter as = 0 + 0, where 0 is the diagonal entry in eq.(22). The LLG equation then reads

$$\frac{1}{dt} \frac{dm}{dt} = m \qquad H_e + -m \qquad \frac{dm}{dt} + \frac{1}{VM_s} L_b : \tag{24}$$

For ultrathin perm alloy Im s, without external eld and crystalline anisotropy, the magnetization is connect in the plane by the shape anisotropy eld given by eq. (15). Equation (24) is a nonlinear dierential equation that can be reformulated as

$$\frac{\mathrm{dm}}{\mathrm{dt}} = f(m; I_0) \tag{25}$$

where f(m; I_0) is a vector function of magnetization m and bias current I_0 . A coording to the theory of dierential equations we not two \equilibrium points at which dm = dt vanishes m $_1$ = (1;0;hp I_0 =[2e $_0$ V M $_s^2$ (N $_z$ N $_x$)]) and m $_2$ = (0;1;0). Expanding eq. (24) at point m $_2$ and keeping only the rst-oder derivatives with respect to the magnetization, i.e.,

$$\frac{dm}{dt} = \frac{Qf}{Qm} ; \qquad (26)$$

where @f=@m is a matrix with elements given by $@f_i=@m_j$. Equation (26) has non-zero solution when

$$\det \frac{\theta f}{\theta m} \Big|_{\text{If } 2} = 0 : \tag{27}$$

This determines the critical current that is necessary to obtain the maximum in-plane rotation, ie., =2:

$$I_{c} = \frac{2e_{0}VM_{s}^{2}P_{x}}{hp} \frac{(N_{z} N_{y})(N_{y} N_{x})}{hp}$$
(28)

The LLG equation augmented by the spin transfer torque for the present conguration suggests a two-state behavior of the magnetization: Below the critical current I_c , the magnetization is pushed out of the initial position (easy axis), then undergoing damped precessions and nally stops along the easy axis but with a small z-component, i.e., the equilibrium given by m_1 . At that position, the demagnetizing eld is balanced by the spin torque. Above the critical current, the magnetization precesses out of the easy axis and rotates to the hard axis without any precession.

We simulate the magnetization dynamics for a polarization p = 0.4 of the F3N and a real part of the mixing conductance $Reg_3^{"\#}A^{-1} = 4:1$ 10^{15} cm². The long sem i-axis, short sem i-axis and the thickness of the perm alloy island are a = 200 nm, b = 190 nm, and d = 5 nm, respectively. The calculated demagnetizing factors are N $_{y} = 0.0224$ and N_x = 0.0191.20 The single-spin density of states in the normal metal is $_{DOS}$ = 2.4 10^{28} eV 1 m 3 .9 The bulk value of the G ilbert damping parameter is 0 = 0.006 and the calculated enhancement of G ilbert damping is 0 = 0.015. 17 A coording to eq. (28), for the above dim ensions, the critical current to achieve = =2 is I_{c} = 139 m A, which agrees well with the numerical results. Below the critical current, e.g., $I_0 = 30 \text{ mA}$, the equilibrium zcomponent determined by the expression of m_1 is 0.0087, which also agrees with the numerical results shown in Fig. 4. The trajectory of the magnetization when suddenly switching on the bias current $I_0 = 30$ mA is depicted in Fig. 2. The magnetization starts from the easy axis (point I in the qure), undergoes a damped oscillation and nally stops at point F, where the spin transfer torque induced by the spin accumulation in the normal metal is balanced by the torque generated by the anisotropy eld. Fig. 7 shows the trajectory of the magnetization under switching on a the bias current $I_0 = 160 \text{ m A}$, which is above the critical current. Figures 5 and 6 are the time dependence of the y and z-com ponents of the free layer magnetization. These gures indicate that the magnetization response to a large current is close to a step function. A smaller size of the permalloy Im requires a smaller critical current, as indicated by eq. (28). In the above simulation, we did not take into account the e ect of a nite RC time for switching on the bias current. A longer rising time of the bias current implies that it takes longer before the magnetization reaches the steady state position. But the magnitude of the critical current does not depend on how the bias current transient.

We nally note that with the dimensions chosen here, the bias currents generate a signicant in-plane rsted eld that may interfere with the spin-torque e ect. It can be avoided, e.g., by spatially separating the free layer from the current path (but within the spin-ip di usion) 14 or by generating a neutralizing rsted eld by a neighboring circuit (suggested by Siegmann).

The advantage of the proposed device mainly comes from the two-state behavior separated by the critical current, which can be utilized as the 0 and 1 states in current controlled mem ory elements. We notice that after the magnetization being switched to the hard axis, only small current is needed to maintain the position stable against thermal uctuations. A nother possible application could be the implementation of such device into spin-torque transistors to achieve the gain of current since the angle of the magnetization in the above device is tunable by the bias. The magnetization can be also used as a spin battery that is \charged" in the high energy state (hard axis) and relaxes a spin current into the normal metal when relaxing to the ground state (easy axis). The induced spin accumulation then creates voltage dierence over the source and drain contacts.

VI. CONCLUSIONS

In this article, the magnetization dynamics of a spin-ip transistor has been studies in the macrospin LLG equation combined with MECT. We found a two-state behavior of the free layer magnetization controlled by the current

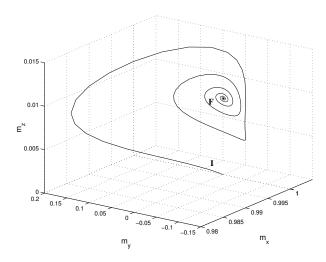


FIG. 2: The trajectory of the magnetization with the bias current $I_0 = 30 \text{ mA}$, which is below the critical current. The magnetization initially aligned along easy axis (x-axis) and after the damped oscillation it stops along the easy axis with small out-of-plane component.

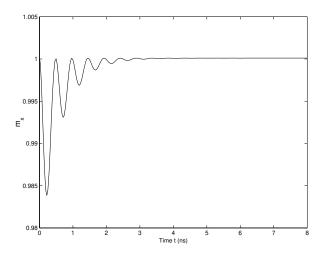


FIG. 3: The x-component of the magnetization vs time (in ns). The bias current is 30 m A.

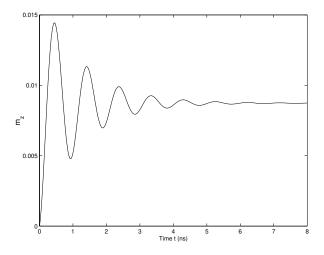


FIG. 4: The z-com ponent of the m agnetization vs time (in ns). The bias current is 30 m A .

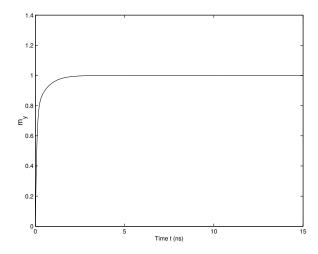
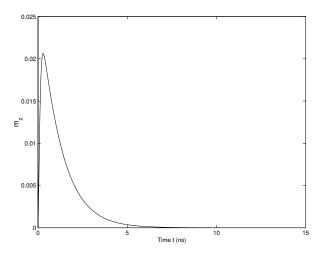


FIG. 5: The y-component of the magnetization vs time. The bias current is 160 mA, which is above the critical current.



 $\textit{F IG. 6:} \ \textit{The z-com ponent of the m agnetization vs time, with bias current 160 mA} \ \textit{that is above the critical current.}$

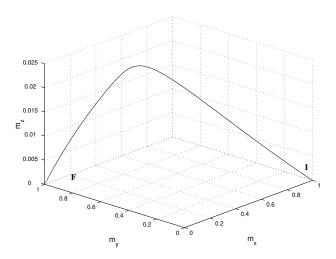


FIG. 7: The trajectory of the magnetization under the bias above the critical current, I_0 = 160 mA. The magnetization initially aligned along easy axis (point I).

induced spin transfer torque and spin pumping. The two regimes are separated by a critical current, below which the magnetization undergoes a damped oscillation and stops along the easy axis with small z-component. Above the critical current, the magnetization rotates to the hard (y-) axis without precession. The critical current is found to depend on the size of the free layer, the aspect ratio of the ellipsoid, and the source-drain contact polarizations. The thermal instability analysis indicates that at room temperature the predicted elects are visible even for very large aspect ratios.

A cknow ledgm ents

W e thank J.C. S lonczew ski and A.K ovalev for discussions. X.W ang thank sH. S aarikoski for his help on SM at Lab. This SM or SM is supported by SM and SM and SM or SM is supported by SM and SM or SM is supported by SM and SM or SM or SM is supported by SM and SM or SM or

```
<sup>1</sup> J.C.Slonczewski, J.Magn.Magn.Mater.159, L1 (1996).
```

- ⁴ E.B.M yers, F.J.A lbert, J.C. Sankey, E.Bonet, R.A.Buhrm an, and D.C.Ralph, Phys.Rev.Lett.89, 195801 (2000).
- ⁵ S. I. Kiselev, J. C. Sankey, I. N. Krivorotov, N. C. Emley, R. J. Schoelkopf, R. A. Buhrman, and D. C. Ralph, Nature (London) 425, 380 (2003).
- 6 W .H.R ippard, M.R.Pufall, S.Kaka, S.E.Russek, and T.J.Silva, Phys.Rev.Lett.92,027201 (2004).
- 7 F.J.Jedem a, A.T.Filip, and B.J.van W ees, Nature 410, 345 (2001).
- ⁸ F.J. Jedem a, H.B. Heersche, A.T. Filip, J.J. A. Baselm ans, and B.J. van Wees, Nature 416, 713 (2002).
- 9 M .Za alon and B .J. van W ees, Phys. Rev. Lett. 91, 186601 (2003).
- ¹⁰ T.K im ura, J.H am rle, Y.O tani, K.T sukagoshi, and A.A oyagi, App. Phys. Lett. 85, 3501 (2004).
- 11 S.O. Valenzuela and M. Tinkham, App. Phys. Lett. 85, 5914 (2004).
- ¹² Y.Ji, A.Ho mann, J.S.Jiang, and S.D.Bader, App. Phys. Lett. 85, 6218 (2004).
- ¹³ G.E.W. Bauer, A.Brataas, Y.Tserkovnyak, and B.J. van Wees, App. Phys. Lett. 82, 3928 (2003).
- 14 T.K im ura, Y.O tani, and J.H am rle, cond-m at/0508559 (2005).
- ¹⁵ A.Brataas, Y.V.Nazarov, and G.E.W.Bauer, Phys.Rev.Lett.84, 2481 (2000).
- ¹⁶ X.W ang, G.E.W. Bauer, and A.Ho mann, cond-mat/0601630 (2006).
- ¹⁷ Y. Tserkovnyak, A. Brataas, and G. E. W. Bauer, Phys. Rev. Lett. 88, 117601 (2002).
- 18 Y. Tserkovnyak, A. Brataas, G. E. W. Bauer, and B. I. Halperin, Rev. Mod. Phys. 77 (2005).
- ¹⁹ M . Johnson and R . H . Silsbee, Phys. Rev. B 37, 5312 (1988).
- ²⁰ J.A.Osbom, Phys. Rev. 67, 351 (1945).
- 21 X .W ang, G .E .W $^{-}$.B auer, Y .T serkovnyak, and A .B rataas, unpublished (2005).
- L.Perko, Di erential Equations and Dynamical Systems (Springer, Berlin, 1996), 2nd ed.
- ²³ K.Xia, P.J.Kelly, G.E.W.Bauer, A.Brataas, and I.Turek, Phys.Rev.B 65, 220401 (2002).

APPENDIX A:SPIN ACCUMULATION AND SPIN TRANSFER TORQUE

The elements of the symmetric matrix $(g;g_3)$ in eq. (12) are listed in the following

$$_{13} = _{31} = [_{3}g_{3} + 2g_{sf} + 2(1 \quad p^{2})g]g_{3}[_{3} \quad (1 \quad p^{2})(1 \quad _{3})]m_{x}m_{z} = G$$
 (A.3)

$$_{22} = (2 g + _{3}g_{3} + 2g_{sf}) [2 g + _{3}g_{3} + 2g_{sf} g_{j} (_{3} (1 g^{2}) (1 _{3})) (m_{x}^{2} + m_{z}^{2})] = G$$
 (A4)

$$33 = [3g_3 + 2g_{sf} + 2(1 \quad p^2)g][2 \quad g + 3g_3 + 2g_{sf} \quad g_s(3 \quad (1 \quad p^2)(1 \quad 3))m_x^2] = G$$

$$(2 \quad g + 3g_3 + 2g_{sf})g_3[3 \quad (1 \quad p^2)(1 \quad 3)]m_y^2 = G$$

$$(A 6)$$

² L.Berger, Phys.Rev.B 54, 9359 (1996).

³ J.A.Katine, F.J.Albert, R.A.Buhm an, E.R.M yers, and D.C.Ralph, Phys. Rev. Lett. 84, 3149 (2000).

where we have introduced the following notation

$$G = (2 g + {}_{3}g_{3} + 2g_{sf})[({}_{3}g_{3} + 2g 2p^{2}g + 2g_{sf})(2 g + 2g_{sf} + (1 p_{3}^{2})(1 {}_{3})g_{3})$$

$$+ 2 (p^{2} 1 +)g({}_{3} (1 p_{3}^{2})(1 {}_{3}))g_{3}m_{v}^{2}];$$
(A 7)

and

$$_{3} = \frac{_{3}}{_{3} + \sim \tanh (d=l_{sd})}$$
: (A 8)

The matrix contained in the expression of spin transfer torque eq. (13) has the following components

 $(2 g + {}_{3}g_{3} + 2g_{sf})[(3 (1 \hat{g})(1)g_{3}m_{v}^{2} + ({}_{3}g_{3} + 2g_{sf} + 2(1 \hat{g})g)m_{z}^{2}] = G:$